Search Notes			

Application No.	Applicant(s)	
10/055,645	TRAVERSAT ET AL.	
Examiner	Art Unit	-
Tan Lien	2141	

SEARCHED			
Class	Subclass	Date	Examiner
709	204	3/17/2005	TL
709	205	3/17/2005	TL
709	226	3/17/2005	TL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Inventor Srch	3/17/2005	TL
Con't Srch	3/17/2005	TL
EAST (US Patent & PGPub, EPO, JPO)	3/17/2005	TL
ACM & IEEE	3/17/2005	TL
Consulted with Paul Kang	3/17/2005	TL